

Notice of References Cited	Application/Control No. 10/701,323	Applicant(s)/Patent Under Reexamination CHOI, WOO HYUK	
	Examiner James A. Dudek	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,646,694 B2	11-2003	Lee, Yen-Chih	349/55
	B	US-2005/0078235	04-2005	Ozaki et al.	349/055
	C	US-6,717,648	04-2004	Tsukao, Kouji	349/192
	D	US-6,664,568	12-2003	Lai, Han-Chung	349/192
	E	US-5,600,460	02-1997	Yamamoto et al.	349/54
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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